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Terms	Documents
L20 and (select\$4 same portion\$3)	0

Database:

US Pre-Grant Publication Full-Text Database  
 US Patents Full-Text Database  
 US OCR Full-Text Database  
 EPO Abstracts Database  
 JPO Abstracts Database  
 Derwent World Patents Index  
 IBM Technical Disclosure Bulletins

Search:

L22

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Clear

Interrupt

### Search History

DATE: Friday, August 13, 2004   [Printable Copy](#)   [Create Case](#)

Set  
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side by  
side

Query

Hit  
Count

Set  
Name  
result set

DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR

<u>L22</u>	L20 and (select\$4 same portion\$3)	0	<u>L22</u>
<u>L21</u>	L20 and (select\$3 same portion\$)	0	<u>L21</u>
<u>L20</u>	L19 and (creat\$3 or recreat\$3 or construct\$3 or reconstruct\$3)	2	<u>L20</u>
<u>L19</u>	L18 not L14	2	<u>L19</u>
<u>L18</u>	L17 not L13	2	<u>L18</u>
<u>L17</u>	L16 and (partition\$3 near table\$1)	3	<u>L17</u>
<u>L16</u>	L15 and (L2 or L3)	48	<u>L16</u>
<u>L15</u>	707/\$.ccls.	21907	<u>L15</u>
<u>L14</u>	L11 and (partition\$3 near table\$1)	1	<u>L14</u>
<u>L13</u>	L11 and (partition\$3 same table\$1)	3	<u>L13</u>
<u>L12</u>	L11 and partition\$3	7	<u>L12</u>
<u>L11</u>	(L2 or L3) and (data near dictionary)	12	<u>L11</u>

DB=USPT; PLUR=YES; OP=OR

<u>L10</u>	6163776.pn.	1	<u>L10</u>
<u>L9</u>	6591272.pn.	1	<u>L9</u>
<i>DB=PGPB; PLUR=YES; OP=OR</i>			
<u>L8</u>	20020143727.pn.	1	<u>L8</u>
<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>			
<u>L7</u>	L6 not L5	3	<u>L7</u>
<u>L6</u>	(L2 or L3) and (DDL or (data near description near language))	5	<u>L6</u>
<u>L5</u>	(L2 or L3) and ((DDL or (data near description near language)) same command\$1)	2	<u>L5</u>
<u>L4</u>	L3 not L2	0	<u>L4</u>
<u>L3</u>	"dump file"	376	<u>L3</u>
<u>L2</u>	dump\$ near file	530	<u>L2</u>
<u>L1</u>	(DDL or (data near description near language)) same command\$1 same (dump\$ near file)	1	<u>L1</u>

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### Search Results -

Terms	Documents
L11 and (partition\$3 near table\$1)	1

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L14

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Set Name   Query side by side	Hit Count	Set Name result set
<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>		
L14   L11 and (partition\$3 near table\$1)	1	L14
L13   L11 and (partition\$3 same table\$1)	3	L13
L12   L11 and partition\$3	7	L12
L11   (L2 or L3) and (data near dictionary)	12	L11
<i>DB=USPT; PLUR=YES; OP=OR</i>		
L10   6163776.pn.	1	L10
L9   6591272.pn.	1	L9
<i>DB=PGPB; PLUR=YES; OP=OR</i>		
L8   20020143727.pn.	1	L8
<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>		
L7   L6 not L5	3	L7
L6   (L2 or L3) and (DDL or (data near description near language)) (L2 or L3) and ((DDL or (data near description near language)) same	5	L6

<u>L5</u>	command\$1)	2	<u>L5</u>
<u>L4</u>	L3 not L2	0	<u>L4</u>
<u>L3</u>	"dump file"	376	<u>L3</u>
<u>L2</u>	dump\$ near file	530	<u>L2</u>
<u>L1</u>	(DDL or (data near description near language)) same command\$1 same (dump\$ near file)	1	<u>L1</u>

END OF SEARCH HISTORY

## Hit List

Clear	Generate Collection	Print	Fwd Refs	Bkwd Refs
Generate OACS				

Search Results - Record(s) 1 through 1 of 1 returned.

☐ 1. Document ID: US 6240428 B1

Using default format because multiple data bases are involved.

L14: Entry 1 of 1

File: USPT

May 29, 2001

US-PAT-NO: 6240428

DOCUMENT-IDENTIFIER: US 6240428 B1

TITLE: Import/export and repartitioning of partitioned objects

DATE-ISSUED: May 29, 2001

INVENTOR-INFORMATION:

NAME	CITY	STATE	ZIP CODE	COUNTRY
Yeung; Sofia	Union City	CA		
Chang; Chung	San Jose	CA		

US-CL-CURRENT: 707/206

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWOC	Draw. D.
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Clear	Generate Collection	Print	Fwd Refs	Bkwd Refs	Generate OACS
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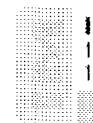
Terms	Documents
L11 and (partition\$3 near table\$1)	1

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